

# WT5700

## Capacitive Touch Key Sensor

### Data Sheet

**Rev. 0.94**

**December 15, 2008**

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Add SSOP24 package  
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Add description

**V0.90 9/9/2008**

Preliminary data sheet.

## Table of Contents

<b>1. GENERAL DESCRIPTION.....</b>	<b>4</b>
1.1. FEATURES.....	4
<b>2. PIN ASSIGNMENT .....</b>	<b>5</b>
2.1. PACKAGE.....	5
2.2. ORDERING INFORMATION .....	5
2.3. PIN DESCRIPTION .....	6
<b>3. FUNCTIONAL BLOCK DIAGRAM .....</b>	<b>7</b>
<b>4. FUNCTIONAL DESCRIPTION.....</b>	<b>8</b>
4.1. CHIP INITIALIZATION .....	8
4.2. SYSTEM CONTROL REGISTER .....	9
4.3. I2C INTERFACE .....	10
4.4. PIN AND REGISTER CONTROL SIGNAL.....	11
4.5. OUTPUT INTERFACE.....	13
4.6. INTERRUPT .....	15
4.7. OUTPUT EXPANDER SHARED WITH OUT[5:0] PINS.....	16
<b>5. ELECTRICAL CHARACTERISTICS .....</b>	<b>17</b>
5.1. ABSOLUTE MAXIMUM RATINGS .....	17
5.2. POWER SUPPLY .....	17
5.3. DIGITAL I/O .....	17
<b>6. TYPICAL APPLICATION CIRCUIT .....</b>	<b>18</b>
6.1. VDD Pin .....	18
6.2. I2C INTERFACE PROTECTION.....	18
6.3. SI[11:0] INPUT PROTECTION .....	18
<b>7. PACKAGE DIMENSION.....</b>	<b>19</b>
7.1. 16PIN SOP .....	19
7.2. 24PIN SSOP.....	20
7.3. 48PIN LQFP.....	21

## 1 General Description

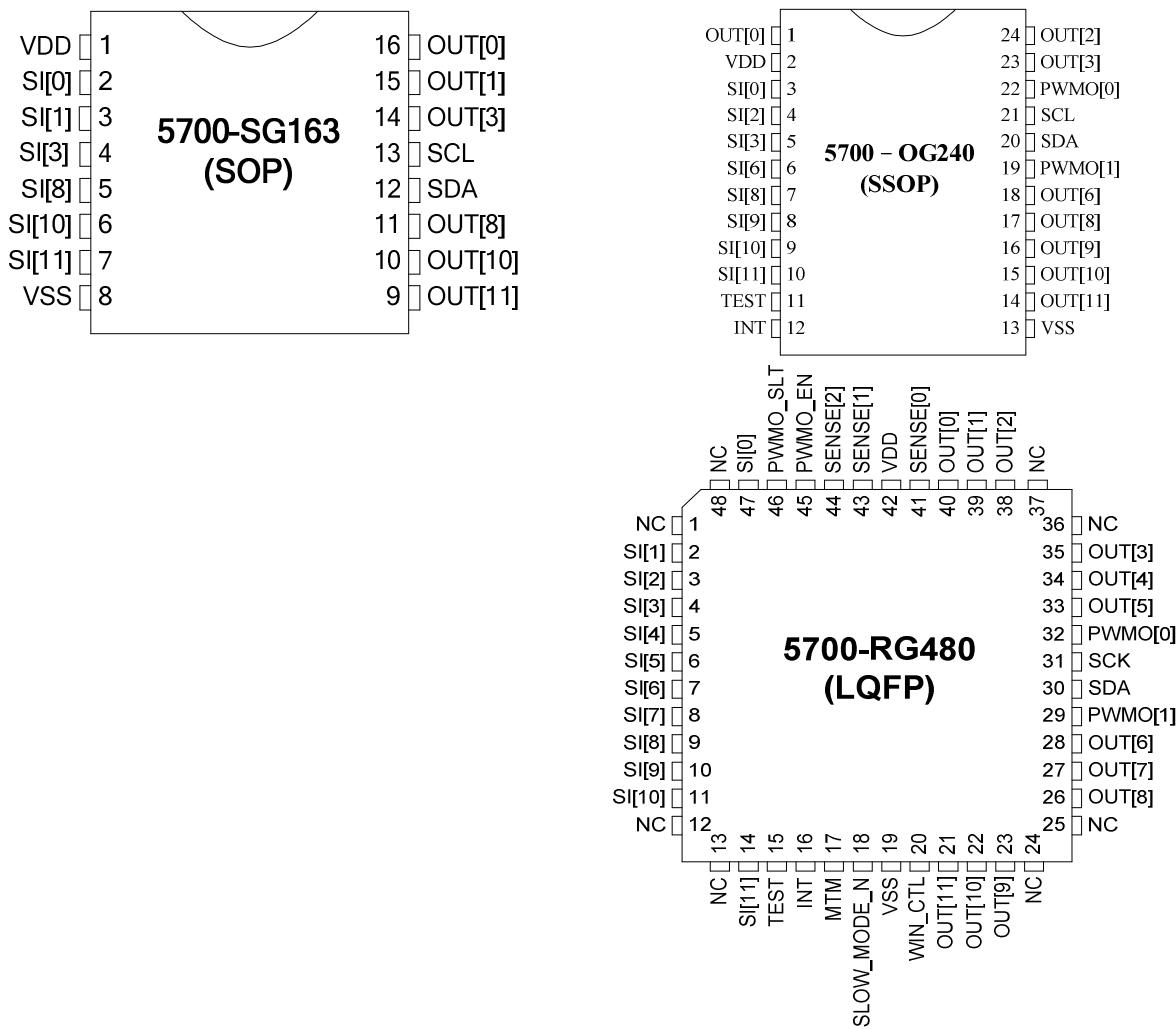
WT5700 is a 1-12 keys capacitive touch key sensor. It is designed for replacing button and also can be configured as matrix scan function. WT5700 has low power consumption, so it is suitable for consumer products and portable applications.

### 1.1. Features

- 1-12 channel input sensor
- Auto sensitivity calibration
- 3 sensitivity option pins
- 2 sensitivity control registers
- Anti-noise circuit embedded
- 24ms response time
- 3 output modes
  - ◆ Direct output: 12 output pad (open drain output)
  - ◆ Serial output(I2C) and include interrupt pin
  - ◆ PWM output
- Output polarity option: active high or active low
- 6 output expander(maximum)
- Open-drain digital output with maximum drain current 8mA
- Wild operating voltage: 2.2V ~ 5.5V
- 3 operation modes: Normal mode, Slow down mode and Sleep mode
- Low operating current
  - ◆ Normal mode
    - 3.3V: Typical 150uA
    - 5.0V: Typical 315uA
  - ◆ Slow down mode
    - 3.3V: Typical 35uA
    - 5.0V: Typical 75uA
  - ◆ Sleep mode
    - 3.3V: Typical 0.6uA
    - 5.0V: Typical 0.7uA
- Package type
  - ◆ LQFP48
  - ◆ SSOP24
  - ◆ SOP16

## 2. Pin Assignment

### 2.1. Package



### 2.2. Ordering information

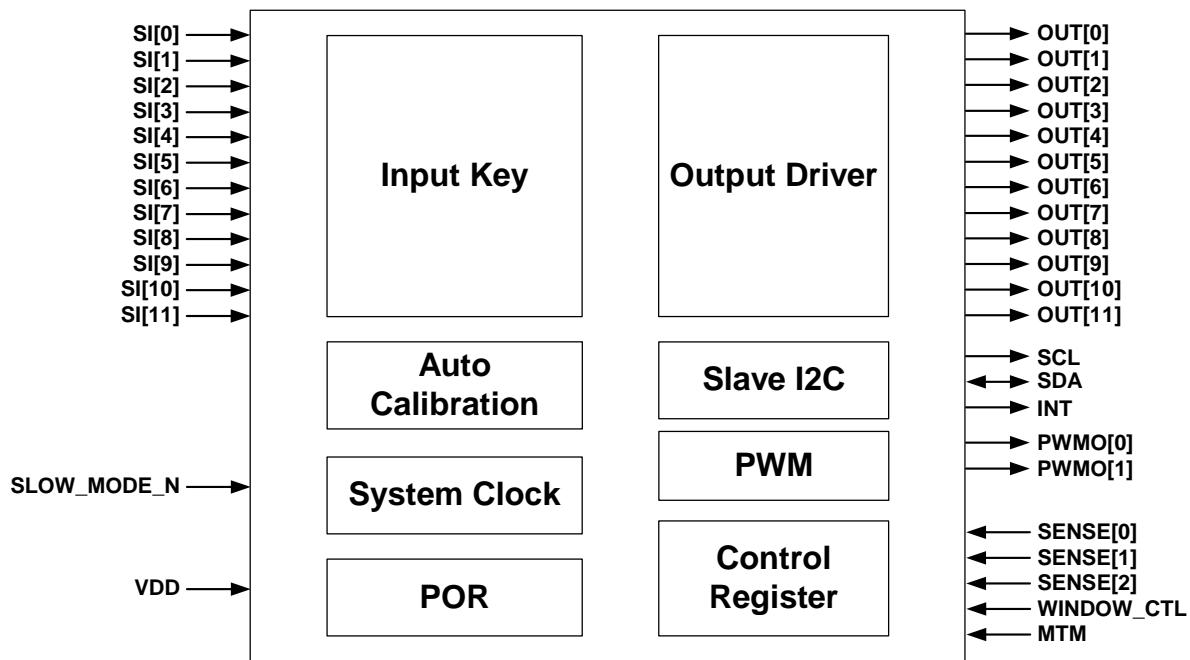
Package Type	Package Outline	Part Number
SOP 16 pin	150mil	5700-SG163WT
SSOP 24 pin	150mil	5700-OG240WT
LQFP 48 pin	7mm * 7 mm	5700-RG480WT

## 2.3. Pin description

R480	O240	S163	Pin Name	I/O	Function Description
47	3	2	SI[0]	A	Capacitive sensor input[0]
2		3	SI[1]	A	Capacitive sensor input[1]
3	4		SI[2]	A	Capacitive sensor input[2]
4	5	4	SI[3]	A	Capacitive sensor input[3]
5			SI[4]	A	Capacitive sensor input[4]
6			SI[5]	A	Capacitive sensor input[5]
7	6		SI[6]	A	Capacitive sensor input[6]
8			SI[7]	A	Capacitive sensor input[7]
9	7	5	SI[8]	A	Capacitive sensor input[8]
10	8		SI[9]	A	Capacitive sensor input[9]
11	9	6	SI[10]	A	Capacitive sensor input[10]
14	10	7	SI[11]	A	Capacitive sensor input[11]
15	11		TEST	I	Test mode pin (internal pull high)
16	12		INT	O	Interruption output
17			MTM	I	Multi touch mode select input (internal pull high)
18			SLOW_MODE_N	I	RC oscillator frequency slow down mode (internal pull high)
19	13	8	VSS	P	ground
20			WIN_CTL	I	Window sensitivity control (internal pull high)
21	14	9	OUT[11]	O	Channel of output[11] (Open drain)
22	15	10	OUT[10]	O	Channel of output[10] (Open drain)
23	16		OUT[9]	O	Channel of output[9] (Open drain)
26	17	11	OUT[8]	O	Channel of output[8] (Open drain)
27			OUT[7]	O	Channel of output[7] (Open drain)
28	18		OUT[6]	O	Channel of output[6] (Open drain)
29	19		PWMO[1]	O	PWMO[1] output
30	20	12	SDA	I/O	I2C SDA
31	21	13	SCL	I	I2C SCL
32	22		PWMO[ 0]	O	PWMO[ 0] output
33			OUT[5]	O	Channel of output[5] (Open drain)
34			OUT[4]	O	Channel of output[4] (Open drain)
35	23	14	OUT[3]	O	Channel of output[3] (Open drain)
38	24		OUT[2]	O	Channel of output[2] (Open drain)
39		15	OUT[1]	O	Channel of output[1] (Open drain)
40	1	16	OUT[0]	O	Channel of output[0] (Open drain)
41			SENSE[0]	I	Sensitivity control [0] (internal pull high)
42	2	1	VDD	P	VDD
43			SENSE[1]	I	Sensitivity control [1] (internal pull high)
44			SENSE[2]	I	Sensitivity control [2] (internal pull high)
45			PWMO_EN	I	PWMO output enable (internal pull high)
46			PWMO_SLT	I	PWMO output mode selection (internal pull high)

A: analog, O: output, I: input, P: power

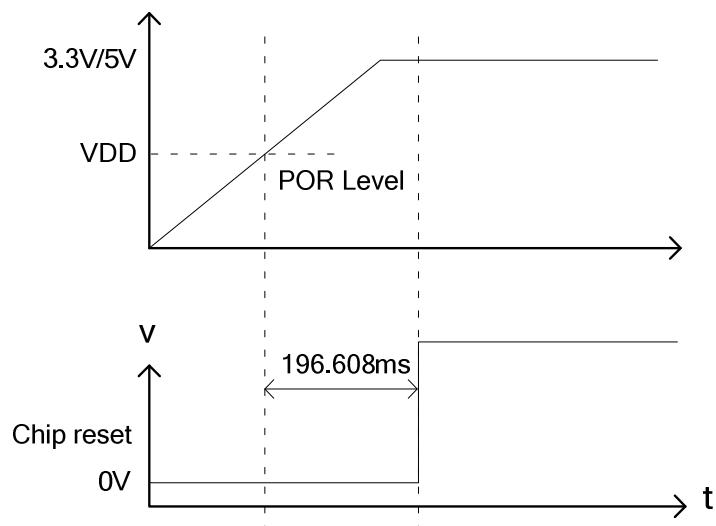
### 3. Functional Block Diagram



## 4. Functional Description

### 4.1. Chip initialization

After VDD rises over POR(power on reset), the internal reset signal will be kept active about 196ms and then be released



## 4.2. System control register

Index	Default	R/W	Bit	Name	Description
00	60	R/W	7	Reserved	
		R/W	6	HEAVY_LOAD_N	Faster sample clock for heavy load. 1: Disable 0: Enable
		R/W	5	SLOW_MODE_N	System and sample oscillator slow down mode for power saving. 1: Normal mode 0: Slow down mode
		W	4	RST_CALB	1: Reset calibration block and new calibration starts 0: normal mode
		R/W	3	ACT_INT_LVL	Interrupt active level 1: High active 0: Low active
		R/W	2	ACT_OUT_LVL	Detect output active level 1: High active 0: Low active
		R/W	1	CTL_SLT	Control signal selection 1: From register setting (controlled by IIC) 0: From input pin (controlled by pin)
		R/W	0	PWR_DN	1: Power down oscillator 0: Normal mode

- (a) If MUC sends I2C command to set CTL\_SLT=1, the function of control input pin will be disable. The control signals include SENSE[2:0], WIN\_CTL, MTM, PWMO\_EN, PWMO\_SLT, SLOW\_MODE\_N, and HEAVY\_LOAD\_N.
- (b) PWR\_DN: MCU sends I2C command to enable/disable power down mode(sleep mode).
- (c) After wake up, MCU must set RST\_CALB=1 to reset calibration block and get new & correct calibration data.

## 4.3. I2C interface

If MUC sends command to set CTL\_SLT=1(index:00H,bit1), the function of control input pin will be disable. Control signals include: SENSE[2:0], WIN\_CTL, MTM, PWMO\_EN, PWMO\_SLT, SLOW\_MODE\_N, HEAVY\_LOAD\_N.

### 4.3.1. Slave I2C Command format

(A) Slave I2C write mode:

Start + saddr(E0) + A + 00 + A + addr + A + data1 + A+ - - - + dataN + A + Stop

(B) Slave I2C read mode:

Start + saddr(E0) + A + 00 + A + addr + Stop +

Start + saddr(E1) + A + data1 + A + - - - + dataN + NACK + Stop

## 4.4. Pin and Register control signal

### 4.4.1. Control register

Index	Default	R/W	Bit	Name	Description
02	F7	R/W	7	PWMO_EN	Enable PWM output
			6	PWMO_SLT	PWM output mode selection 1: PWM[0] output SI[0]/SI[2]/SI[4]/SI[6]/SI[8]/SI[10] PWM[1] output SI[1]/SI[3]/SI[5]/SI[7]/SI[9]/SI[11] 0: PWM[0] output SI[0]/SI[1]...../SI[10]/SI[11]
			5	MTM	Default =1 1: Multi touch mode 0: Single touch mode
			4	WIN_CTL	Window sensitivity control 1: No-windows sensitivity 0:1/2-windows sensitivity
			3	Reserved	
			2-0	SENSE1[2:0]	Sensitivity level selection for group 1 (SI[11:7], SI[5:1]) 000: 4 clock 001: 8 clock 010: 12 clock 011: 20 clock 100: 32 clock 101: 48 clock 110: 72 clock 111: 96 clock
03	07	R/W	7-3	Reserved	
			2-0	SENSE2[2:0]	Sensitivity level selection for group 2 (SI[6], SI[0]) 000: 4 clock 001: 8 clock 010: 12 clock 011: 20 clock 100: 32 clock 101: 48 clock 110: 72 clock 111: 96 clock

(a) Initial "are same as status of "INPUT" pin.

"CONTROL" data includes SENSE[2:0], WIN\_CTL, MTM, PWMO\_EN, PWMO\_SLT, SLOW\_MODE\_N, HEAVY\_LOAD\_N.

(b) SI sensitivity source from pin or register

	CTL_SLT=0	CTL_SLT=1
SI[11:7], SI[5:1]	SENSE[2:0] pins	SENSE1[2:0] register
SI[6], SI[0]	SENSE[2:0] pins	SENSE2[2:0] register

(c) MTM=0 : single touch mode. The lower number input has more prior output. SI[0] is the most prior output and SI[11] is the most posterior

#### 4.4.2. Sensitivity and Window control: SENSE[2:0] & WIN\_CTL

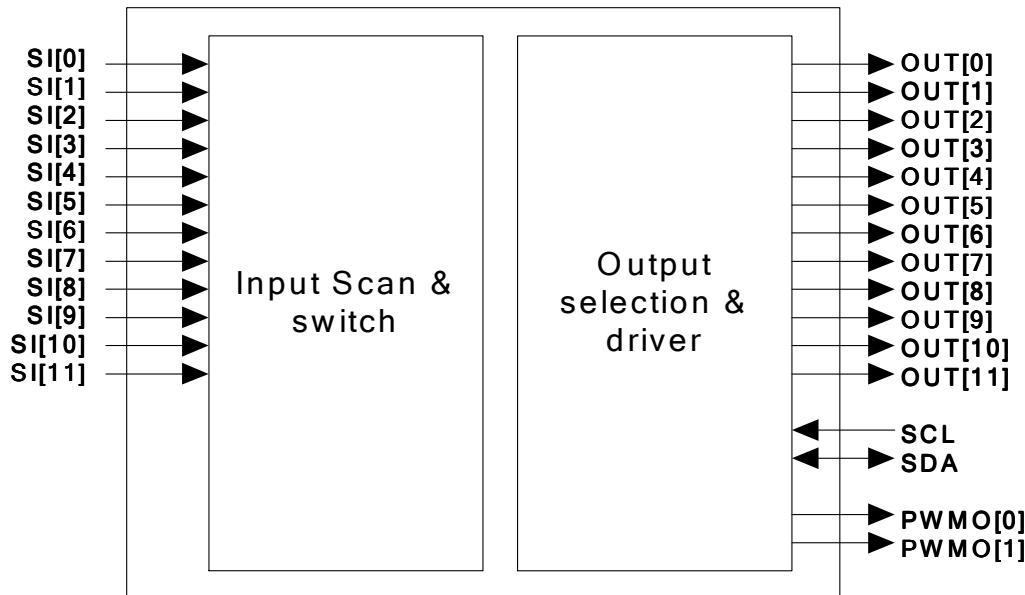
- (A) The key detector is the value (different clock numbers) of clock difference for detecting from no-touching to touching.

SENSE[2:0]			Clock difference
0	0	0	4
0	0	1	8
0	1	0	12
0	1	1	20
1	0	0	32
1	0	1	48
1	1	0	72
1	1	1	96

- (B) The key from touching to release detect by WIN\_CTL.

SENSE [2:0]			WIN_CTL	
			1 No-W	0 1/2-W
0	0	0	4	2
0	0	1	8	4
0	1	0	12	6
0	1	1	20	10
1	0	0	32	16
1	0	1	48	24
1	1	0	72	36
1	1	1	96	48

## 4.5. Output interface



### 4.5.1. Direct output : OUT[11:0]

Direct mode : IN pad (SI[0]-SI[11]) => output pad(OUT[0]-OUT[11])

- (1) Multi touch mode(MTM=1, (index:20H,bit5))
- (2) Single touch mode(MTM=0, (index:20H,bit5))

### 4.5.2. PWMO output: PWMO[1:0]

- (1) PWMO\_SLT register :

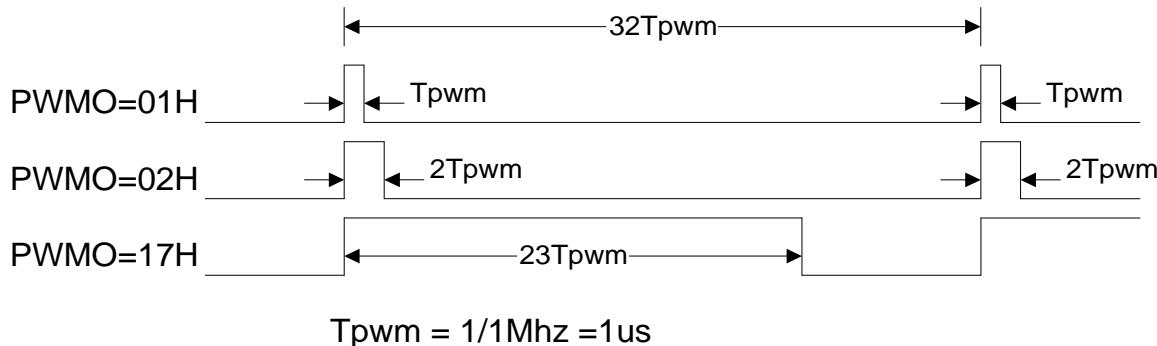
- (a) PWMO\_SLT=1 : PWMO[0] outputs the detection of SI[0]/SI[2]/SI[4]/SI[6]/SI[8]/SI[10]  
PWMO[1] outputs the detection of SI[1]/SI[3]/SI[5]/SI[7]/SI[9]/SI[11]
- (b) PWMO\_SLT=0 : PWMO[0] outputs the detection of SI[0]/SI[1]...../SI[10]/SI[11]  
PWMO[1] is no use.

Touched PAD	PWMO_SLT=0	PWMO_SLT=1	
	PWMO[0] output	PWMO[0] output	PWMO[1] output
SI[0]	01H	02H	
SI[1]	03H		02H
SI[2]	05H	06H	
SI[3]	07H		06H
SI[4]	09H	0AH	
SI[5]	0BH		0AH
SI[6]	0DH	0EH	
SI[7]	0FH		0EH
SI[8]	11H	12H	
SI[9]	13H		12H
SI[10]	15H	16H	
SI[11]	17H		16H

(2) PWMO base clock = system clock = 1Mhz, => PWMO period = 1Mhz/32=31.25kHz

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(3) PWMO-outputs only support single-touch mode



#### 4.5.3. I2C serial interface

(1) Sensor data(KEY\_TOUCH[11:0]) always supports multi-touch mode.

Index	Default	R/W	Bit	Name	Description
08	00	R	7-4	Reserved	
			3-0	KEY_TOUCH [11:8]	0000: No key of SI[11:8] has been touched 0001: SI[8] key has been touched 0010: SI[9] key has been touched 0011: SI[9:8] keys have been touched   1111: SI[11:8] keys have been touched
09	00	R	7-0	KEY_TOUCH [7:0]	0000_0000: No key of SI[7:0] has been touched 0000_0001: SI[0] key has been touched 0000_0010: SI[1] key has been touched 0000_0011: SI[1:0] keys have been touched   1111_1111: SI[7:0] keys have been touched

(2) SI[11:0] Sample counter.

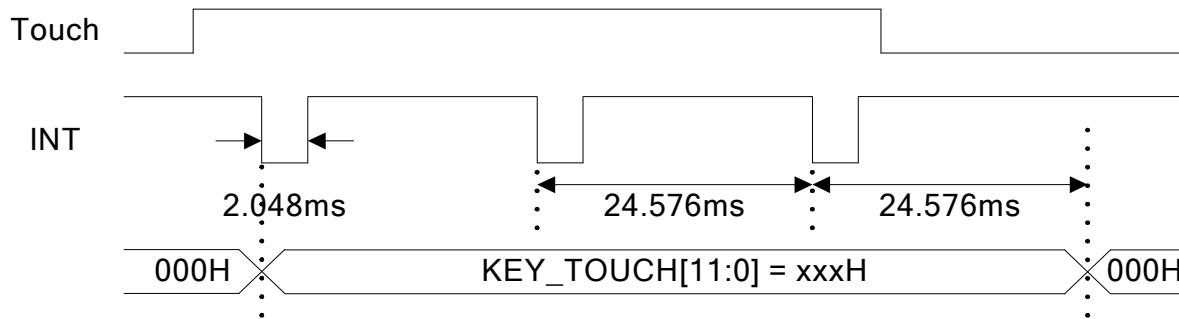
Index	Default	R/W	Bit	Name	Description
0E	30	R/W	7-4	Reserved"3"	must be "3"
			3-0	CHAN_SEL[3:0]	Select key input channel. 0000: Select sensor input SI[0] 0001: Select sensor input SI [1]   1010: Select sensor input SI [10] 1011: Select sensor input SI [11] 1100~1111: no define
1E	00	R	7-3	Reserved	
	00	R	2-0	SMP_CNT[10:8]	Sample counter[10:8] *
1F	00	R	7-0	SMP_CNT[7:0]	Sample counter[7:0] *

(a) After the sample channel is selected by CHAN\_SEL[3:0], **MCU must wait at least 24ms** and then read sample counter.

## 4.6. Interrupt

### 4.6.1. WT5700 ⇔ MCU interface timing

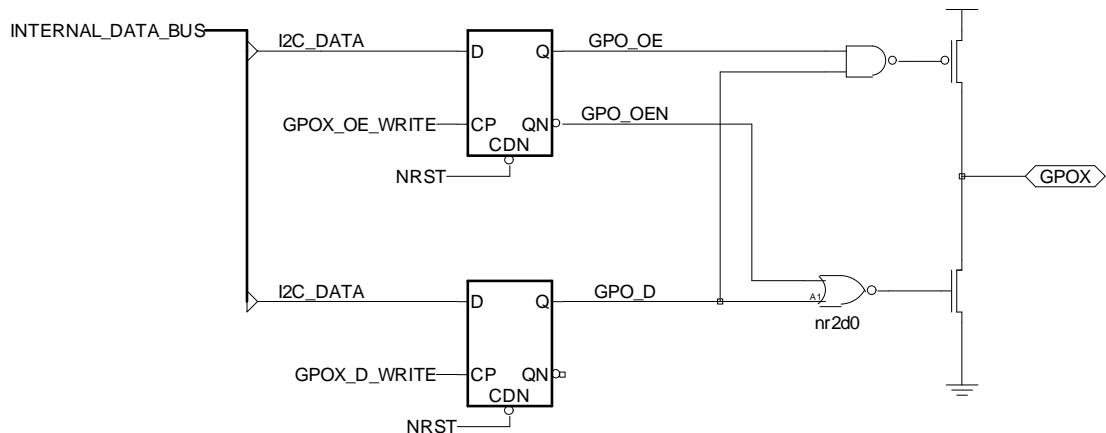
When any key pads are touched, the INT pin generates periodic pulse which period is approximate 24ms and the active time is 2ms. ACT\_INT\_LVL register((index:00H,bit3)) controls to program H/L active level of INT pin



After "INT" is active, MCU must read KEY\_TOUCH among 24ms. Otherwise, MCU maybe read KEY\_TOUCH[11:0]=000H

## 4.7. Output expander shared with OUT[5:0] pins

The GPO[0] ~ GPO[5] are the general purpose output shared with KEY detector output pads. When GPO\_OE is enable, it is a general purpose output port and it could source /sink 4mA.



Index	Default	R/W	Bit	Name	Description
04	00	R/W	7-6	Reserved	
			5-0	GPO_OE[5:0]	GPO output enable 1: GPO_D[5:0] output 0: detector OUT[5:0] output
05	00	W	7-6	Reserved	
			5-0	GPO_D[5:0]	Write: GPO output data

## 5. Electrical Characteristics

### 5.1. Absolute Maximum Ratings

Parameter	Min.	Max.	Units
DC Supply Voltage (VDD)	-0.3	5.5	V
Storage temperature	-25	125	°C
Operating temperature	-10	85	°C

\*Note: Stresses above those listed may cause permanent damage to the devices

### 5.2. Power Supply

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
I <sub>VDD5V</sub>	Normal operation current at 5V operating	No load on output		315		uA
I <sub>VDD33V</sub>	Normal operation current at 3.3V operating	No load on output		150		uA
I <sub>SLOW5V</sub>	Slow down mode current at 5V operating	No load on output		75		uA
I <sub>SLOW33V</sub>	Slow down mode current at 3.3V operating	No load on output		35		uA
I <sub>SLEEP5V</sub>	Sleep mode current at 5V operating	No load on output			1	uA
I <sub>SLEEP33V</sub>	Sleep mode current at 3.3V operating	No load on output			1	uA

### 5.3. Digital I/O

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
V <sub>IH</sub>	Input high Voltage		0.7V <sub>DD</sub>		V <sub>DD</sub> +0.3	V
V <sub>IL</sub>	Input low voltage		-0.3		0.2VDD	V
V <sub>OH</sub>	Output high voltage (Note 1)	I <sub>OH</sub> = 4mA at VDD= 3.3V	2.4			V
V <sub>OH</sub>	Output high voltage (Note 1)	I <sub>OH</sub> = 4mA at VDD= 5V	4			V
V <sub>OL</sub>	Output low voltage (Note 2)	I <sub>OL</sub> = 4mA			0.4	V
V <sub>OL</sub>	Output low voltage (Note 3)	I <sub>OL</sub> = 8mA			0.4	V
I <sub>OZ</sub>	Tri-state leakage current	V <sub>O</sub> = 0 or 3.3V		±0.01	±1	μA
R <sub>PU1</sub>	Pull up resistor (Note 4)	VDD=5V		25		KΩ
R <sub>PU2</sub>	Pull up resistor (Note 5)	VDD=5V		10		MΩ

Note 1: Including all output PAD.

Note 2: Including INT, SDA and PWMO[1:0] output PAD

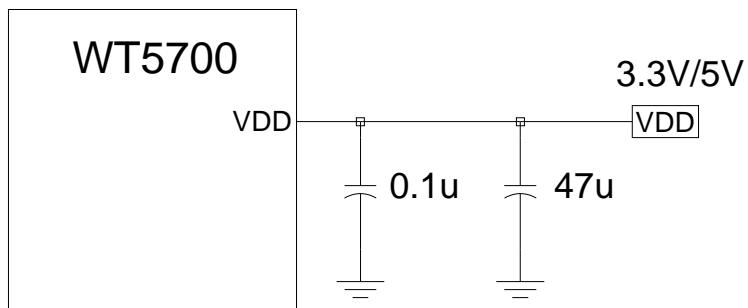
Note 3: Including OUT[11:0] output PAD

Note 4: Including SCL and SDA

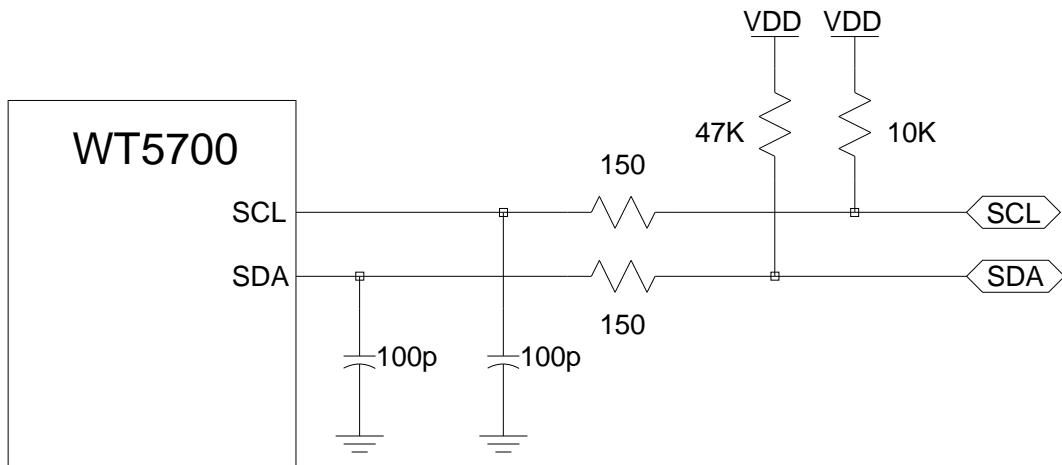
Note 5: Including TEST, MTM, SLOW\_MODE\_N, WIN\_CTL, SENSE[2:0], PWMO\_EN and PWMO\_SLT

## 6. Typical Application Circuit

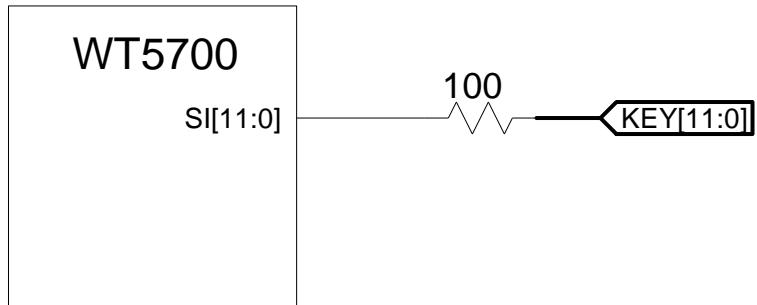
### 6.1. VDD Pin



### 6.2. I2C Interface Protection

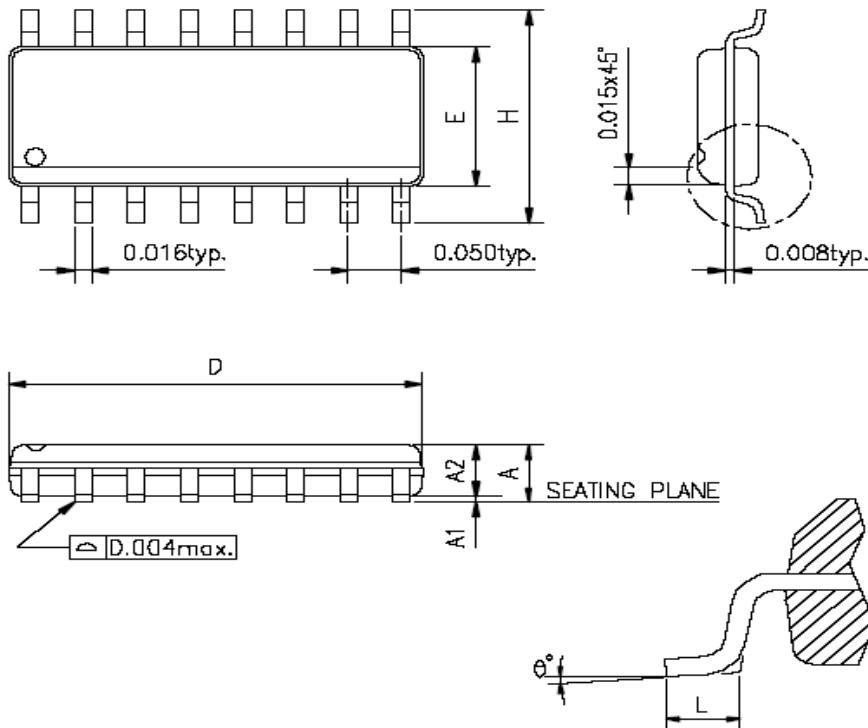


### 6.3. SI[11:0] Input Protection



## 7. Package Dimension

7.1. 16



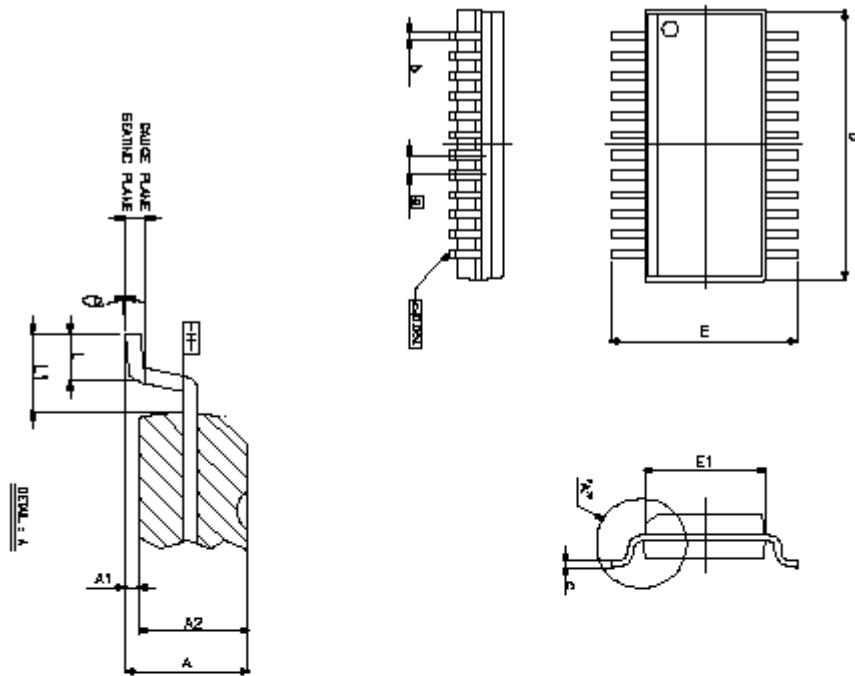
SYMBOLS	MIN.	MAX.
A	0.053	0.069
A1	0.004	0.010
D	0.386	0.394
E	0.150	0.157
H	0.228	0.244
L	0.016	0.050
$\emptyset$	0	8

UNIT : INCH

## NOTES:

- 1.JEDEC OUTLINE : MS-012 AC
- 2.DIMENSIONS "D" DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS MOLD FLASH, PROTRUSIONS AND GATE BURRS SHALL NOT EXCEED .15mm (.006in) PER SIDE.
- 3.DIMENSIONS "E" DOES NOT INCLUDE INTER-LEAD FLASH, OR PROTRUSIONS. INTER-LEAD FLASH AND PROTRUSIONS SHALL NOT EXCEED .25mm (.010in) PER SIDE.

## 7.2. 24pin SSOP



### NOTES:

1. DIMENSION D DOES NOT INCLUDE MOLD PROTRUSIONS OR GATE BURRS.  
MOLD PROTRUSIONS AND GATE BURRS SHALL NOT EXCEED 0.006" PER  
SIDE. DIMENSION E1 DOES NOT INCLUDE INTERLEAD MOLD PROTRUSIONS.  
INTERLEAD MOLD PROTRUSIONS SHALL NOT EXCEED 0.010" PER SIDE.

2. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION/INTRUSION.  
ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.004" TOTAL IN EXCESS OF  
b DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR INTRUSION  
SHALL NOT REDUCE DIMENSION b BY MORE THAN 0.002" AT LEAST.

SYMBOLS	MIN.	NOM.	MAX.
A	-	0.084	0.070
A1	0.004	-	-
A2	-	-	0.059
b	0.0108	-	0.012
c	0.006	-	0.010
D	0.335	0.341	0.346
E	0.228	0.236	0.244
E1	0.150	0.154	0.157
E2	0.020	0.025	0.030
L	0.015	0.025	-
L1	-	0.041	-
g	-	-	B

UNIT : INCH

### 7.3. 48pin LQFP

